

Computational Astrophysics I: Introduction and basic concepts

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Insertion: data analysis

arithmetic mean

$$\langle x \rangle = \frac{1}{n} \sum_{i=1}^n x_i \quad (1)$$

Problem: calculation of the mean for measured data

- Eq. (1) must be evaluated again for every new data point
- for $n \gg 1$ and at the same time $x_i \ll 1$ numerical inaccuracy for strict use of Eq. (1) because of $\rightarrow$ saturation in x_i

$\rightarrow$ hence: definition of the recursive mean:

$$\langle x \rangle_i = \frac{i-1}{i} \langle x \rangle_{i-1} + \frac{1}{i} x_i \quad (2)$$

proof:

$$i-1 : \langle x \rangle_{i-1} = \frac{x_1 + \dots + x_{i-1}}{i-1} \quad (3)$$

$$i : \langle x \rangle_i = \frac{x_1 + \dots + x_{i-1} + x_i}{i} \quad (4)$$

$$= \frac{(i-1) \frac{x_1 + \dots + x_{i-1}}{i-1} + x_i}{i} \quad (5)$$

$$= \frac{i-1}{i} \langle x \rangle_{i-1} + \frac{x_i}{i} \quad (6)$$

q.e.d.

analogously: **recursive variance**

$$\sigma_i^2 = \frac{i-1}{i} \sigma_{i-1}^2 + \frac{1}{i-1} (x_i - \langle x \rangle_i)^2 \quad (7)$$

proof similar as for recursive mean

correction of a single value:

$$\begin{aligned} \langle x \rangle_{\text{new}} &= \langle x \rangle_{\text{old}} + \frac{x_{\text{new}} - x_{\text{old}}}{n} \\ \sigma_{\text{new}}^2 &= \sigma_{\text{old}}^2 + \frac{x_{\text{new}}^2 - x_{\text{old}}^2}{n} - \frac{x_{\text{new}} - x_{\text{old}}}{n} \left(\langle x \rangle_{\text{old}} + \frac{x_{\text{new}} - x_{\text{old}}}{n} \right) \end{aligned} \quad (8)$$

proof for the correction of the mean:

$$\begin{aligned} \langle x \rangle_{\text{new}} &= \frac{1}{n} \left(\sum_{i=1}^n x_i - x_{\text{old}} + x_{\text{new}} \right) = \\ &= \langle x \rangle_{\text{old}} + \frac{x_{\text{new}} - x_{\text{old}}}{n} \quad \text{q.e.d.} \end{aligned} \quad (9)$$

We already know

Straight line fit without errors

$$y = b \cdot x + a \quad (10)$$

$$\text{with slope } b = \frac{\frac{1}{n-1} \sum_{i=1}^n (x_i - \langle x \rangle)(y_i - \langle y \rangle)}{\frac{1}{n-1} \sum_{i=1}^n (x_i - \langle x \rangle)^2} \quad (11)$$

$$\text{and } a = \langle y \rangle - b \cdot \langle x \rangle \quad (12)$$

quality of fit $y = a + bx$ measured by χ^2 :

$$\chi^2(a, b) = \sum_{i=1}^n \left(\frac{y_i - a - bx_i}{\sigma_i} \right)^2 \quad (13)$$

with error σ_i in measuring of y_i (x_i exact)

Best fit for χ^2 minimum, hence (see also *Numerical Recipes*)

$$0 \stackrel{!}{=} \frac{\partial \chi^2}{\partial a} = -2 \sum_{i=1}^n \frac{y_i - a - bx_i}{\sigma_i^2} \quad (14)$$

$$0 \stackrel{!}{=} \frac{\partial \chi^2}{\partial b} = -2 \sum_{i=1}^n \frac{x_i(y_i - a - bx_i)}{\sigma_i^2} \quad (15)$$

can be rewritten as system of equations:

$$a \sum_{i=1}^n \frac{1}{\sigma_i^2} + b \sum_{i=1}^n \frac{x_i}{\sigma_i^2} = \sum_{i=1}^n \frac{y_i}{\sigma_i^2} \quad (16)$$

$$a \sum_{i=1}^n \frac{x_i}{\sigma_i^2} + b \sum_{i=1}^n \frac{x_i^2}{\sigma_i^2} = \sum_{i=1}^n \frac{x_i y_i}{\sigma_i^2} \quad (17)$$

$$(18)$$

solution for the system:

$$a = \frac{\sum_{i=1}^n \frac{x_i^2}{\sigma_i^2} \sum_{i=1}^n \frac{y_i}{\sigma_i^2} - \sum_{i=1}^n \frac{x_i}{\sigma_i^2} \sum_{i=1}^n \frac{x_i y_i}{\sigma_i^2}}{\sum_{i=1}^n \frac{1}{\sigma_i^2} \sum_{i=1}^n \frac{x_i^2}{\sigma_i^2} - \left(\sum_{i=1}^n \frac{x_i}{\sigma_i^2} \right)^2} \quad (19)$$

$$b = \frac{\sum_{i=1}^n \frac{1}{\sigma_i^2} \sum_{i=1}^n \frac{x_i y_i}{\sigma_i^2} - \sum_{i=1}^n \frac{x_i}{\sigma_i^2} \sum_{i=1}^n \frac{y_i}{\sigma_i^2}}{\sum_{i=1}^n \frac{1}{\sigma_i^2} \sum_{i=1}^n \frac{x_i^2}{\sigma_i^2} - \left(\sum_{i=1}^n \frac{x_i}{\sigma_i^2} \right)^2} \quad (20)$$

errors in a and b from error propagation for a quantity f :

$$\sigma_f^2 = \sum_{i=1}^n \sigma_i^2 \left(\frac{\partial f}{\partial y_i} \right)^2 \quad (21)$$

where

$$\frac{\partial a}{\partial y_i} = \frac{\sum_{i=1}^n \frac{x_i^2}{\sigma_i^2} - x_i \sum_{i=1}^n \frac{x_i}{\sigma_i^2}}{\sigma_i^2 \left(\sum_{i=1}^n \frac{1}{\sigma_i^2} \sum_{i=1}^n \frac{x_i^2}{\sigma_i^2} - \left(\sum_{i=1}^n \frac{x_i}{\sigma_i^2} \right)^2 \right)} \quad (22)$$

$$\frac{\partial b}{\partial y_i} = \frac{x_i \sum_{i=1}^n \frac{1}{\sigma_i^2} - \sum_{i=1}^n \frac{x_i}{\sigma_i^2}}{\sigma_i^2 \left(\sum_{i=1}^n \frac{1}{\sigma_i^2} \sum_{i=1}^n \frac{x_i^2}{\sigma_i^2} - \left(\sum_{i=1}^n \frac{x_i}{\sigma_i^2} \right)^2 \right)} \quad (23)$$

adding up according to Eq. (21)

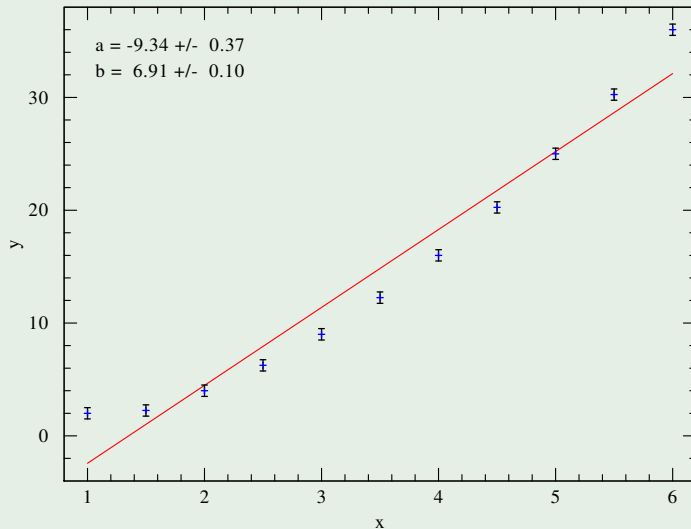
$$\sigma_a^2 = \frac{\sum_{i=1}^n \frac{x_i^2}{\sigma_i^2}}{\sum_{i=1}^n \frac{1}{\sigma_i^2} \sum_{i=1}^n \frac{x_i^2}{\sigma_i^2} - \left(\sum_{i=1}^n \frac{x_i}{\sigma_i^2} \right)^2} \quad (24)$$

$$\sigma_b^2 = \frac{\sum_{i=1}^n \frac{1}{\sigma_i^2}}{\sum_{i=1}^n \frac{1}{\sigma_i^2} \sum_{i=1}^n \frac{x_i^2}{\sigma_i^2} - \left(\sum_{i=1}^n \frac{x_i}{\sigma_i^2} \right)^2} \quad (25)$$

Caution!

This (purely formal) error may drastically underestimate the real error in a , b !

Example: bad fit but small error



→ small formal error, as
error in the measurements is
small

but:

→ model does not fit to
data

Our original case: errors σ_i not available.

Then: Set $\sigma_i = 1$ in equations for a , b and multiply factor $\sqrt{\frac{\chi^2}{n-2}}$ to the formal errors

$$\sigma_a^2 = \frac{\sum_{i=1}^n x_i^2}{n \sum_{i=1}^n x_i^2 - (\sum_{i=1}^n x_i)^2} \sqrt{\frac{\chi^2}{n-2}} \quad (26)$$

$$\sigma_b^2 = \frac{n}{n \sum_{i=1}^n x_i^2 - (\sum_{i=1}^n x_i)^2} \sqrt{\frac{\chi^2}{n-2}} \quad (27)$$

$$\text{where } \chi^2 = \sum_{i=1}^n (y_i - a - bx_i)^2 \quad (28)$$

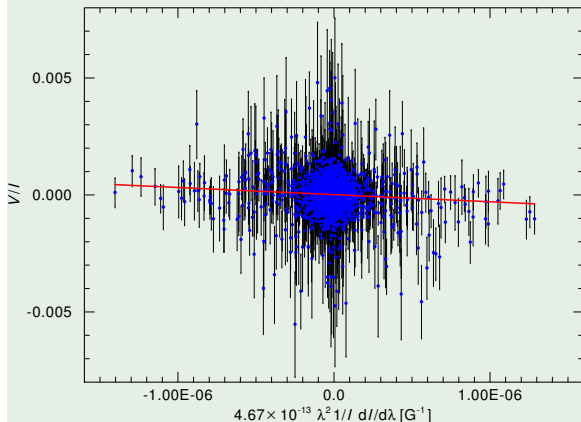
Estimating the errors in fit variables (e.g., the slope b)

Methods:

- ① formal error from errors in measuring in $y_i \rightarrow$ without consideration of the fit quality χ^2
- ② error from χ^2 without consideration of the errors in measuring y_i

$\rightarrow$ usually results in an underestimation of σ_b

Example: measuring the magnetic field from polarization



Stokes I : intensity

Stokes $V = I_R - I_L$ (so: right-hand circularly polarized – left-hand circularly polarized)

→ V/I : fraction of polarized light

→ $\lambda^2/I dI/d\lambda$: Zeeman shift

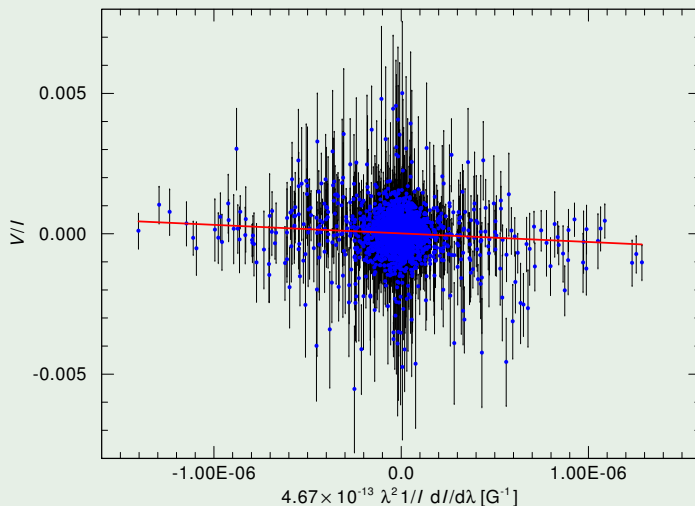
Idea: for broad spectral lines (Balmer lines in WD, WR emission lines) Zeeman splitting not directly detectable because of Doppler shifts. Therefore: measure “line displacement” per pixel per line together with V/I .

No B-field $\rightarrow$ no correlation. Otherwise, slope gives longitudinal $\langle B_z \rangle$

$$\frac{V}{I} = -\frac{g_{\text{eff}} e \lambda^2}{4\pi m_e c^2} \frac{1}{I} \frac{dI}{d\lambda} \langle B_z \rangle \quad (29)$$

with average effective Landé factor

Example: measuring the magnetic field from polarization



→ slope dominated by only few data points?

Problem: the distribution of b is usually not known

Idea: construct a distribution with help of *Bootstrapping*

Construction of a Bootstrapping distribution

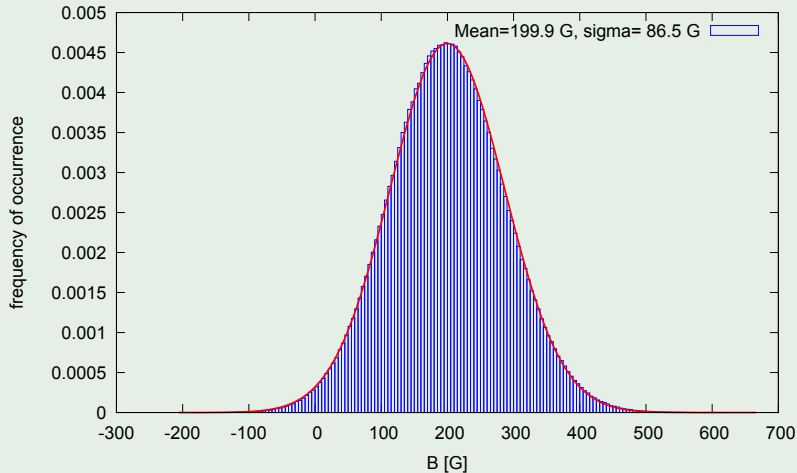
random sample j by random drawing of n data (x_i, y_i) from the complete set of n data with *repetition* and determination of b_j . Repeating m -times this procedure, where $m \gg n$.

In each random sample are only $\sim 1/e \approx 37\%$ of the original data because of *repetitions*.

→ result: sample of m measured quantity b_j .

Then, determination of the expectation value, variance, etc. for the obtained bootstrapping sample, e.g.,

Example: magnetic field B_z from polarization



→ interpretation: $\mu > 2\sigma \rightarrow$ marginal detection (5% probability that actually $B_z = 0$)